

April 2000



# FQPF14N30

## 300V N-Channel MOSFET

### **General Description**

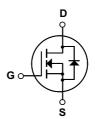
These N-Channel enhancement mode power field effect transistors are produced using Fairchild's proprietary, planar stripe, DMOS technology.

This advanced technology has been especially tailored to minimize on-state resistance, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode. These devices are well suited for high efficiency switching DC/DC converters, switch mode power supply.

#### **Features**

- 8.5A, 300V,  $R_{DS(on)} = 0.29\Omega @V_{GS} = 10 \text{ V}$
- Low gate charge (typical 30 nC)
- Low Crss (typical 23 pF)
- · Fast switching
- 100% avalanche tested
- · Improved dv/dt capability





## Absolute Maximum Ratings T<sub>C</sub> = 25°C unless otherwise noted

Symbol	Parameter		FQPF14N30	Units
V <sub>DSS</sub>	Drain-Source Voltage		300	V
I <sub>D</sub>	Drain Current - Continuous (T <sub>C</sub> = 25°C	<b>(</b> )	8.5	А
	- Continuous (T <sub>C</sub> = 100°	C)	5.4	А
I <sub>DM</sub>	Drain Current - Pulsed	(Note 1)	34	А
$V_{GSS}$	Gate-Source Voltage		± 30	V
E <sub>AS</sub>	Single Pulsed Avalanche Energy	(Note 2)	600	mJ
I <sub>AR</sub>	Avalanche Current	(Note 1)	8.5	А
E <sub>AR</sub>	Repetitive Avalanche Energy	(Note 1)	5.0	mJ
dv/dt	Peak Diode Recovery dv/dt	(Note 3)	4.5	V/ns
P <sub>D</sub>	Power Dissipation (T <sub>C</sub> = 25°C)		50	W
	- Derate above 25°C		0.4	W/°C
T <sub>J</sub> , T <sub>STG</sub>	Operating and Storage Temperature Range		-55 to +150	°C
T <sub>I</sub>	Maximum lead temperature for soldering purposes,		300	°C
.r	1/8" from case for 5 seconds		300	C

## **Thermal Characteristics**

Symbol	Parameter	Тур	Max	Units
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case		2.5	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient		62.5	°C/W

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Symbol	Parameter	Test Conditions	Min	Тур	Max	Units
Off Cha	aracteristics					
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	V <sub>GS</sub> = 0 V, I <sub>D</sub> = 250 μA	300			V
ΔBV <sub>DSS</sub> / ΔT <sub>J</sub>	Breakdown Voltage Temperature Coefficient	I <sub>D</sub> = 250 μA, Referenced to 25°C		0.34		V/°C
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	V <sub>DS</sub> = 300 V, V <sub>GS</sub> = 0 V			1	μА
		V <sub>DS</sub> = 240 V, T <sub>C</sub> = 125°C			10	μΑ
I <sub>GSSF</sub>	Gate-Body Leakage Current, Forward	V <sub>GS</sub> = 30 V, V <sub>DS</sub> = 0 V			100	nA
I <sub>GSSR</sub>	Gate-Body Leakage Current, Reverse	V <sub>GS</sub> = -30 V, V <sub>DS</sub> = 0 V			-100	nA
On Cha	aracteristics					
V <sub>GS(th)</sub>	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_{D} = 250 \mu\text{A}$	3.0		5.0	V
R <sub>DS(on)</sub>	Static Drain-Source On-Resistance	V <sub>GS</sub> = 10 V, I <sub>D</sub> = 4.25 A		0.23	0.29	Ω
9 <sub>FS</sub>	Forward Transconductance	V <sub>DS</sub> = 50 V, I <sub>D</sub> = 4.25 A (Note 4)		7.9		S
		$V_{DS} = 25 \text{ V}, V_{GS} = 0 \text{ V},$			_	pF
	Output Capacitance	f = 1.0 MHz		200	260	pF
C <sub>oss</sub>	Output Capacitance Reverse Transfer Capacitance			200 23	260 30	
C <sub>rss</sub>	' '					pF
C <sub>rss</sub> Switch	Reverse Transfer Capacitance	f = 1.0 MHz				pF
C <sub>rss</sub>	Reverse Transfer Capacitance ing Characteristics	f = 1.0 MHz V <sub>DD</sub> = 150 V, I <sub>D</sub> = 14.4 A,		23	30	pF pF
C <sub>rss</sub> Switchi t <sub>d(on)</sub>	Reverse Transfer Capacitance  ing Characteristics  Turn-On Delay Time	f = 1.0 MHz		23	30 55	pF pF
C <sub>rss</sub> Switchi  t <sub>d(on)</sub>	Reverse Transfer Capacitance  ing Characteristics  Turn-On Delay Time  Turn-On Rise Time	f = 1.0 MHz V <sub>DD</sub> = 150 V, I <sub>D</sub> = 14.4 A,		23 22 145	30 55 300	pF pF ns
$\begin{aligned} & \mathbf{C}_{\text{rss}} \\ & \mathbf{Switchi} \\ & \mathbf{t}_{\text{d(on)}} \\ & \mathbf{t}_{\text{r}} \\ & \mathbf{t}_{\text{d(off)}} \\ & \mathbf{t}_{\text{f}} \end{aligned}$	Reverse Transfer Capacitance  ing Characteristics  Turn-On Delay Time  Turn-On Rise Time  Turn-Off Delay Time	f = 1.0  MHz $V_{DD} = 150 \text{ V}, I_D = 14.4 \text{ A},$ $R_G = 25 \Omega$		22 145 45	30 55 300 100	pF pF pF
$\begin{aligned} & C_{rss} \\ & \textbf{Switch} \\ & t_{d(on)} \\ & t_{r} \\ & t_{d(off)} \end{aligned}$	Reverse Transfer Capacitance  ing Characteristics  Turn-On Delay Time  Turn-On Rise Time  Turn-Off Delay Time  Turn-Off Fall Time	$f = 1.0 \text{ MHz}$ $V_{DD} = 150 \text{ V, } I_{D} = 14.4 \text{ A,}$ $R_{G} = 25 \Omega$ (Note 4, 5) $V_{DS} = 240 \text{ V, } I_{D} = 14.4 \text{ A,}$	  	22 145 45 70	30 55 300 100 150	pF pF ns ns ns
$\begin{array}{c} \mathbf{C}_{\text{rss}} \\ \\ \mathbf{Switchi} \\ \mathbf{t}_{\text{d(on)}} \\ \mathbf{t}_{\text{r}} \\ \\ \mathbf{t}_{\text{d(off)}} \\ \mathbf{t}_{\text{f}} \\ \\ \mathbf{Q}_{\text{g}} \end{array}$	Reverse Transfer Capacitance  ing Characteristics  Turn-On Delay Time  Turn-On Rise Time  Turn-Off Delay Time  Turn-Off Fall Time  Total Gate Charge	$f = 1.0 \text{ MHz}$ $V_{DD} = 150 \text{ V}, \text{ I}_{D} = 14.4 \text{ A},$ $R_{G} = 25 \Omega$ (Note 4, 5)	   	22 145 45 70 30	55 300 100 150 40	pF pF ns ns ns ns
$C_{rss}$ Switchi $t_{d(on)}$ $t_r$ $t_{d(off)}$ $t_f$ $Q_g$ $Q_{gs}$ $Q_{gd}$	Reverse Transfer Capacitance  ing Characteristics  Turn-On Delay Time  Turn-Off Delay Time  Turn-Off Delay Time  Turn-Off Fall Time  Total Gate Charge  Gate-Source Charge  Gate-Drain Charge	$f = 1.0 \text{ MHz}$ $V_{DD} = 150 \text{ V}, I_D = 14.4 \text{ A},$ $R_G = 25 \Omega$ (Note 4, 5) $V_{DS} = 240 \text{ V}, I_D = 14.4 \text{ A},$ $V_{GS} = 10 \text{ V}$ (Note 4, 5)		22 145 45 70 30 7.5	30 55 300 100 150 40	pF pF ns ns ns ns nc nC
$C_{rss}$ Switchi $t_{d(on)}$ $t_r$ $t_{d(off)}$ $t_f$ $Q_g$ $Q_{gs}$ $Q_{gd}$ Drain-S	Reverse Transfer Capacitance  ing Characteristics  Turn-On Delay Time  Turn-On Rise Time  Turn-Off Delay Time  Turn-Off Fall Time  Total Gate Charge  Gate-Source Charge  Gate-Drain Charge	$f = 1.0 \text{ MHz}$ $V_{DD} = 150 \text{ V}, \text{ I}_{D} = 14.4 \text{ A},$ $R_{G} = 25 \Omega$ $(Note 4, 5)$ $V_{DS} = 240 \text{ V}, \text{ I}_{D} = 14.4 \text{ A},$ $V_{GS} = 10 \text{ V}$ $(Note 4, 5)$ and Maximum Ratings		22 145 45 70 30 7.5	30 55 300 100 150 40	pF pF ns ns ns ns nc nC
$C_{rss}$ Switchi $t_{d(on)}$ $t_r$ $t_{d(off)}$ $t_f$ $Q_g$ $Q_{gs}$ $Q_{gd}$ Drain-S	Reverse Transfer Capacitance  ing Characteristics  Turn-On Delay Time  Turn-Off Delay Time  Turn-Off Fall Time  Total Gate Charge  Gate-Source Charge  Gate-Drain Charge  Source Diode Characteristics as Maximum Continuous Drain-Source Diode	$f = 1.0 \text{ MHz}$ $V_{DD} = 150 \text{ V}, \text{ I}_{D} = 14.4 \text{ A},$ $R_{G} = 25 \Omega$ $(Note 4, 5)$ $V_{DS} = 240 \text{ V}, \text{ I}_{D} = 14.4 \text{ A},$ $V_{GS} = 10 \text{ V}$ $(Note 4, 5)$ and Maximum Ratings $DODE = 10 \text{ V}$ $(Note 4, 5)$ $(Note 4, 5)$		22 145 45 70 30 7.5	30 55 300 100 150 40 	pF pF ns ns ns ns nc nC nC
$\begin{array}{c} \textbf{Switchi} \\ \textbf{Switchi} \\ \textbf{t}_{d(on)} \\ \textbf{t}_{r} \\ \textbf{t}_{d(off)} \\ \textbf{t}_{f} \\ \textbf{Q}_{g} \\ \textbf{Q}_{gs} \\ \textbf{Q}_{gd} \\ \\ \textbf{Drain-S} \\ \textbf{I}_{SM} \\ \end{array}$	Reverse Transfer Capacitance  ing Characteristics  Turn-On Delay Time  Turn-Off Delay Time  Turn-Off Fall Time  Total Gate Charge  Gate-Source Charge  Gate-Drain Charge  Source Diode Characteristics au  Maximum Continuous Drain-Source Diode F	$f = 1.0 \text{ MHz}$ $V_{DD} = 150 \text{ V}, \text{ I}_{D} = 14.4 \text{ A},$ $R_{G} = 25 \Omega$ $(\text{Note 4, 5})$ $V_{DS} = 240 \text{ V}, \text{ I}_{D} = 14.4 \text{ A},$ $V_{GS} = 10 \text{ V}$ $(\text{Note 4, 5})$ $\text{nd Maximum Ratings}$ $\text{ode Forward Current}$ Forward Current		22 145 45 70 30 7.5 13	30 55 300 100 150 40  	pF pF ns ns ns ns nC nC A A
$C_{rss}$ Switchi $t_{d(on)}$ $t_r$ $t_{d(off)}$ $t_f$ $Q_g$ $Q_{gs}$ $Q_{gd}$ Drain-S	Reverse Transfer Capacitance  ing Characteristics  Turn-On Delay Time  Turn-Off Delay Time  Turn-Off Fall Time  Total Gate Charge  Gate-Source Charge  Gate-Drain Charge  Source Diode Characteristics as Maximum Continuous Drain-Source Diode	$f = 1.0 \text{ MHz}$ $V_{DD} = 150 \text{ V}, \text{ I}_{D} = 14.4 \text{ A},$ $R_{G} = 25 \Omega$ $(Note 4, 5)$ $V_{DS} = 240 \text{ V}, \text{ I}_{D} = 14.4 \text{ A},$ $V_{GS} = 10 \text{ V}$ $(Note 4, 5)$ and Maximum Ratings $DODE = 10 \text{ V}$ $(Note 4, 5)$ $(Note 4, 5)$		22 145 45 70 30 7.5 13	30 55 300 100 150 40 	pF pF ns ns ns ns nc nC nC

- **Notes:**1. Repetitive Rating : Pulse width limited by maximum junction temperature 2. L = 13.8mH,  $J_{AS}$  = 8.5A,  $V_{DD}$  = 50V,  $R_{G}$  = 25  $\Omega$ , Starting  $T_{J}$  = 25°C 3.  $J_{SD}$  ≤ 14.4A,  $J_{AS}$  = 4.50  $J_{AS}$  = 500  $J_{$

# **Typical Characteristics**

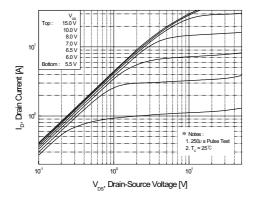


Figure 1. On-Region Characteristics

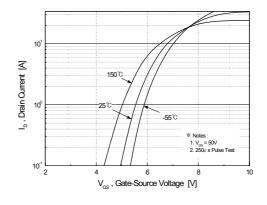


Figure 2. Transfer Characteristics

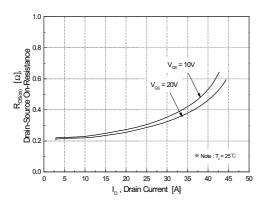


Figure 3. On-Resistance Variation vs. Drain Current and Gate Voltage

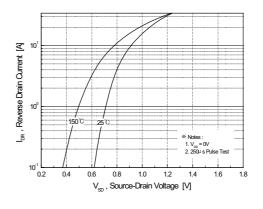


Figure 4. Body Diode Forward Voltage Variation vs. Source Current and Temperature

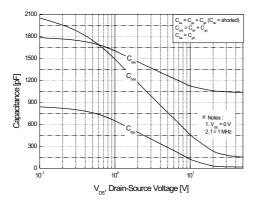


Figure 5. Capacitance Characteristics

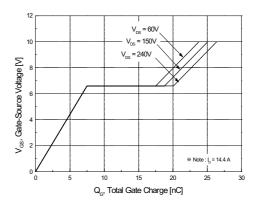
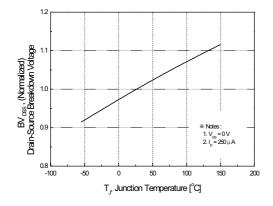


Figure 6. Gate Charge Characteristics

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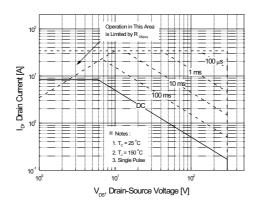
# Typical Characteristics (Continued)



(Sozial September 1) 1.5 (Sozial September 1)

Figure 7. Breakdown Voltage Variation vs. Temperature

Figure 8. On-Resistance Variation vs. Temperature



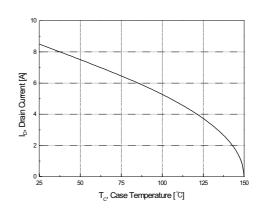


Figure 9. Maximum Safe Operating Area

Figure 10. Maximum Drain Current vs. Case Temperature

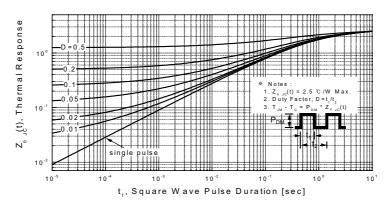
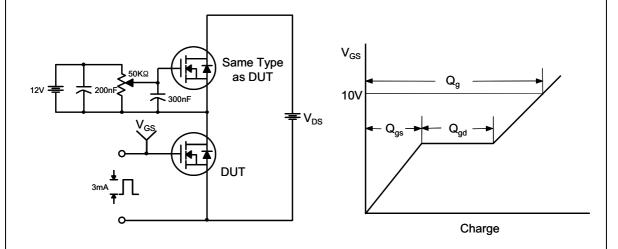


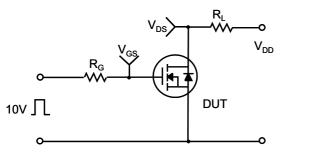
Figure 11. Transient Thermal Response Curve

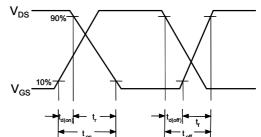
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## **Gate Charge Test Circuit & Waveform**

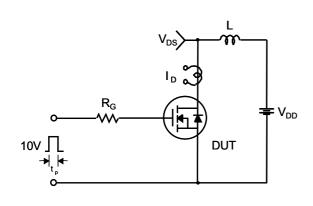


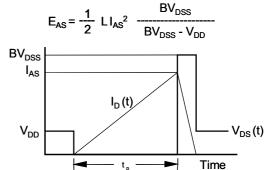
## **Resistive Switching Test Circuit & Waveforms**



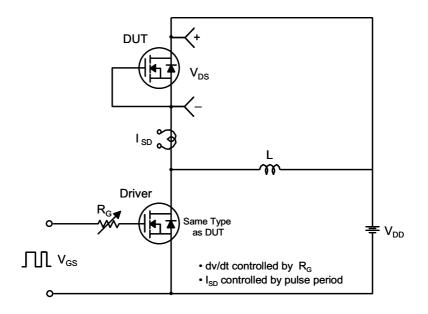


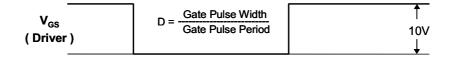
## **Unclamped Inductive Switching Test Circuit & Waveforms**

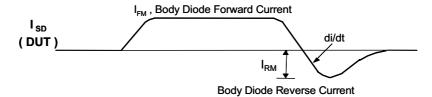




## Peak Diode Recovery dv/dt Test Circuit & Waveforms







V<sub>DS</sub>
( DUT )

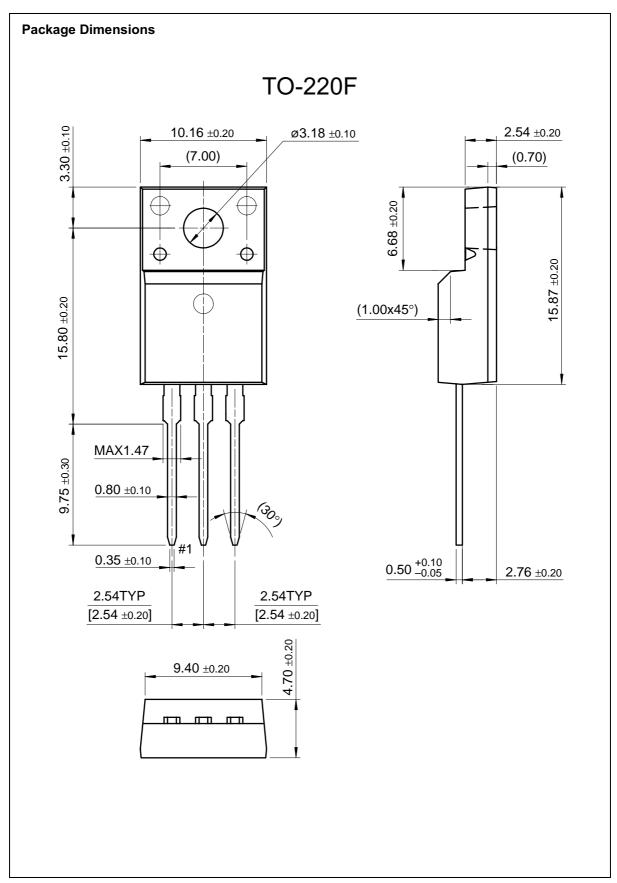
Body Diode Recovery dv/dt

V<sub>DD</sub>

Body Diode

Forward Voltage Drop

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result in significant injury to the user.

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